



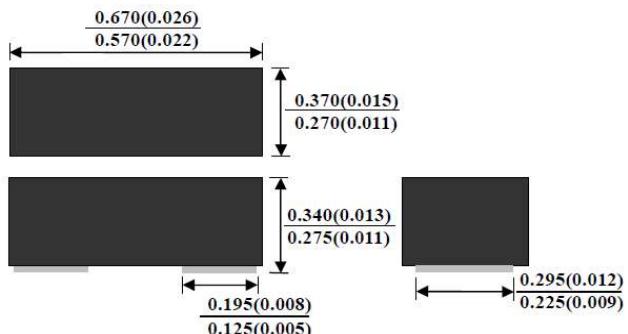
# SE05L3BPDB

## ESD PROTECTION DIODE

### FEATURES

- Bi-directional ESD protection
- IEC61000-4-2 30kV(Air), 25kV(Contact)
- Ultra small SMD package:0201
- Operating voltage: 5V
- Suffix "H" indicates Halogen-free parts, ex. SE05L3BPDBH

DFN0603 (0201)



### APPLICATIONS

- USB 2.0 and USB 3.0
- HDMI 1.3/1.4 and HDMI 2.0
- LVDS Interfaces
- FM Antenna
- PCI Express

Dimensions in inches and (millimeters)

### MECHANICAL DATA

Case : DFN0603(0201) standard package

Terminals : Au / Sn plated, Solderable per MIL-STD-750,  
method 2026

### PIN CONFIGURATION



### Maximum Ratings (Rating at 25°C ambient temperature unless otherwise specified)

Parameter	Symbol	Value	Units
IEC 61000-4-2 ESD Voltage <sup>(1)</sup> Air Model Contact Model	V <sub>ESD</sub>	±30 ±25	KV
Maximum Peak Pulse Current tp=8/20μs	I <sub>PP</sub>	4.5	A
Operating Junction Temperature	T <sub>j</sub>	-55 to +125	°C
Storage Temperature Range	T <sub>stg</sub>	-55 to +150	°C



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### Electrical Characteristics ( $T_a = 25^\circ C$ unless otherwise specified)

Parameter	Test conditions	Symbol	Min	Typ	Max	Unit
Reverse stand off voltage	-	$V_{RWM}$	-	-	5	V
Reverse breakdown voltage	$I_T = 1\text{mA}$	$V_{(BR)}$	-	-	10	V
Reverse leakage current	$V_{RWM} = 5\text{V}$	$I_R$	-	50	100	nA
Clamping voltage	$I_{pp} = 1\text{A}, t_p = 8/20\text{\mu s}$ $I_{pp} = 3\text{A}, t_p = 8/20\text{\mu s}$	$V_C$	-	-	11	V
Clamping Voltage <sup>(2)</sup>	$I_{pp} = -5\text{A}, t_{lp} = 0.2/100\text{ ns}$ $I_{pp} = +5\text{A}, t_{lp} = 0.2/100\text{ ns}$ $I_{pp} = -30\text{A}, t_{lp} = 0.2/100\text{ ns}$ $I_{pp} = +30\text{A}, t_{lp} = 0.2/100\text{ ns}$	$V_C$	-	-11 11 -18 18	- - - -	V
Dynamic Resistance <sup>(2)(3)(4)</sup>	$t_p = 100\text{ns}$		-	0.31	-	Ohms
Junction capacitance	$V_R = 0\text{V}, f = 1\text{MHz}$	$C_J$	-	0.25	0.35	pF

Note:

1-ESD gun return path connected to ESD ground reference plane.

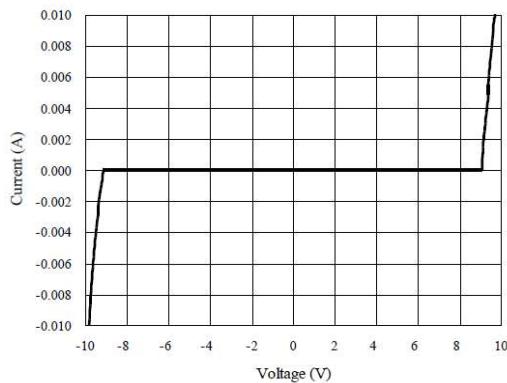
2-Transmission Line Pulse Test (TLP) Settings:  $t_p = 100\text{ns}, t_r = 0.2\text{ns}, I_{TLP}$  and  $V_{TLP}$  averaging window:  $t_1 = 70\text{ns}$  to  $t_2 = 90\text{ns}$ .

3-Dynamic resistance calculated from  $I_{TLP} = -5\text{A}$  to  $I_{TLP} = -30\text{A}$  and  $I_{TLP} = +5\text{A}$  to  $I_{TLP} = +30\text{A}$

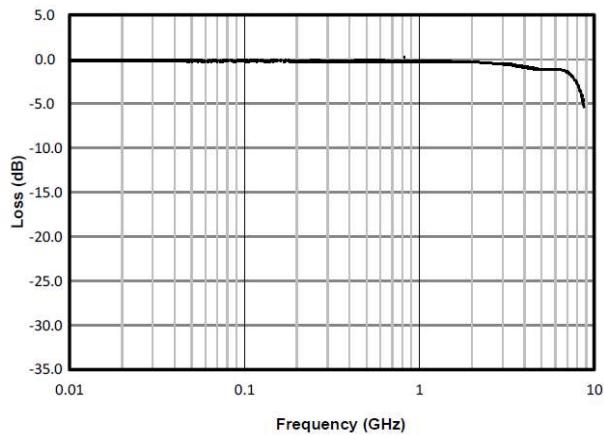
4-Guaranteed by design. Not production tested

### RATINGS AND CHARACTERISTIC CURVES

#### Voltage Sweeping of I/O to I/O



#### Typical Insertion Loss (S21)



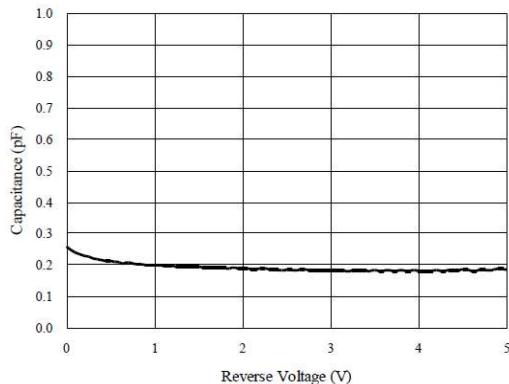


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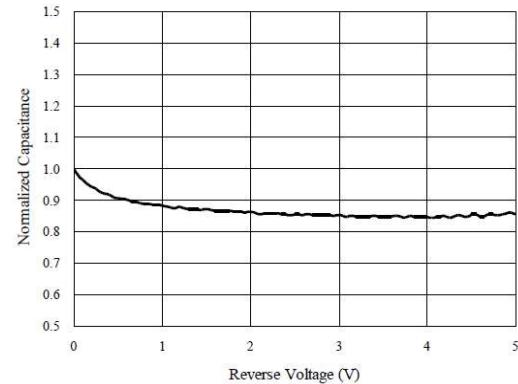
## ESD PROTECTION DIODE

### Capacitance vs. Voltage of I/O to GND ( $f = 1\text{MHz}$ )

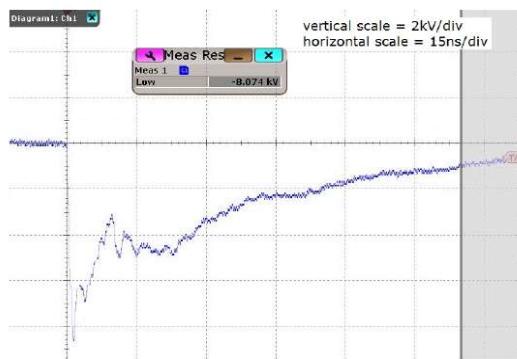
Capacitance vs. Reverse Voltage



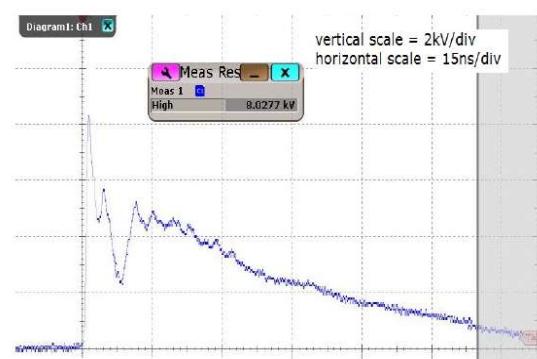
Normalized Capacitance vs. Reverse Voltage



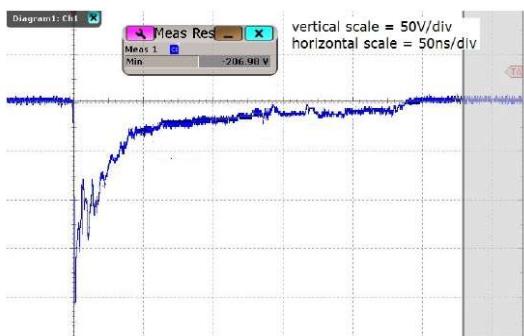
Unclamped -8 kV ESD pluse waveform  
(IEC61000-4-2 network)



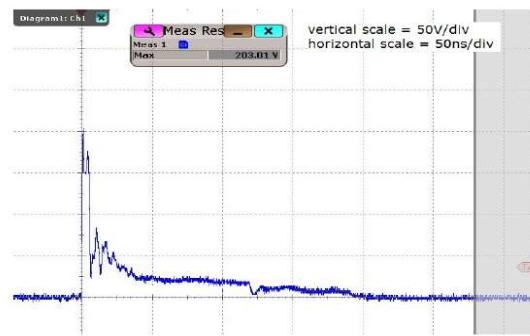
Unclamped +8 kV ESD pluse waveform  
(IEC61000-4-2 network)



Unclamped -8 kV ESD pluse waveform  
(IEC61000-4-2 network)



Unclamped +8 kV ESD pluse waveform  
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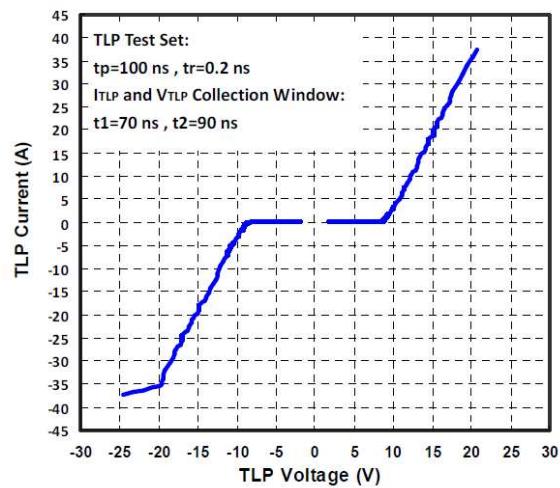




# SE05Q1BPDB

## ESD PROTECTION DIODE

TLP Measurement

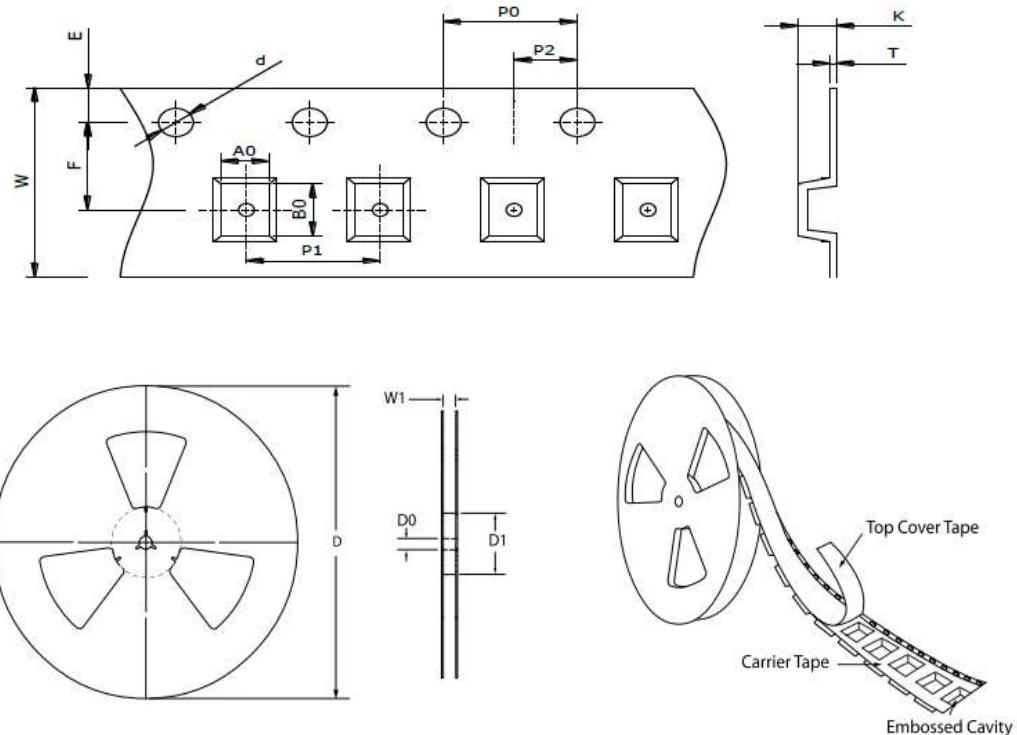




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## ESD PROTECTION DIODE

### TAPE & REEL SPECIFICATION



Item	Symbol	DFN0603 (0201)
Carrier width	A <sub>0</sub>	0.37 ± 0.05
Carrier length	B <sub>0</sub>	0.67 ± 0.05
Carrier depth	K	0.50 ± 0.05
Sprocket hole	d	1.50 ± 0.10
Reel outside diameter	D	178.00 ± 2.00
Feed hole width	D <sub>0</sub>	13.00 ± 0.20
Reel inner diameter	D <sub>1</sub>	MIN. 54.00
Sprocke hole position	E	1.75 ± 0.10
Punch hole position	F	3.50 ± 0.10
Sprocke hole pitch	P <sub>0</sub>	4.00 ± 0.10
Punch hole pitch	P <sub>1</sub>	4.00 ± 0.10
Embossmnt center	P <sub>2</sub>	2.00 ± 0.10
Overall tape thickness	T	0.18 ± 0.05
Tape width	W	8.00 ± 0.20
Reel width	W <sub>1</sub>	MAX. 13.50

### ORDER INFORMATION

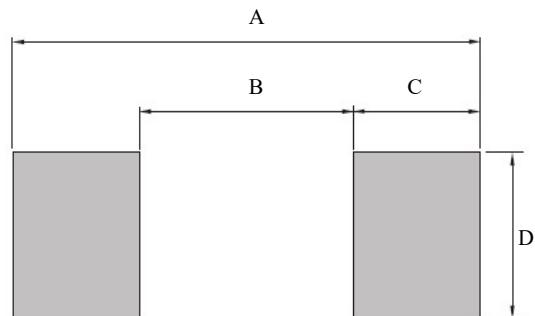
Package	Reel Size	Quantity
DFN0603 (0201)	7"	10,000



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## ESD PROTECTION DIODE

### SUGGESTED SOLDER PAD LAYOUT



PACKAGE	A	B	C	D
DFN0603 (0201)	0.64	0.20	0.22	0.36